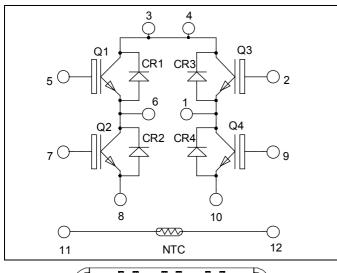
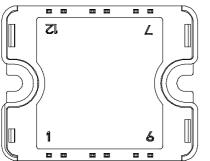


Full bridge Trench + Field Stop IGBT4 Power Module





Pins 3/4 must be shorted together

# Absolute maximum ratings

# APTGL40H120T1G

# $V_{CES} = 1200V$ $I_{C} = 40A$ @ Tc = 80°C

#### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

### Features

- Trench + Field Stop IGBT 4 Technology
  - Low voltage drop
  - Low leakage current
  - Low switching losses
  - Low tail current
  - Soft recovery parallel diodes
  - Low diode VF
  - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring

### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS compliant

Symbol	Parameter		Max ratings	Unit
V <sub>CES</sub>	Collector - Emitter Breakdown Voltage		1200	V
I <sub>C</sub>	Continuous Collector Current	$T_C = 25^{\circ}C$	65	
	Continuous Collector Current $T_{\rm C} = 80$		40	А
I <sub>CM</sub>	Pulsed Collector Current	$T_C = 25^{\circ}C$	70	
V <sub>GE</sub>	Gate – Emitter Voltage		±20	V
P <sub>D</sub>	Maximum Power Dissipation	$T_C = 25^{\circ}C$	220	W
RBSOA	Reverse Bias Safe Operating Area	$T_{j} = 150^{\circ}C$	70A @ 1100V	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

www.microsemi.com



#### All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified ....

Electrical Characteristics										
Symbol	Characteristic	Test Conditions	Test Conditions			Max	Unit			
I <sub>CES</sub>	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 1200V$				250	μA			
V	Collector Emitter saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$		1.85	2.25	V			
V <sub>CE(sat)</sub>		$I_C = 35A$	$T_{j} = 150^{\circ}C$		2.25		v			
V <sub>GE(th)</sub>	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 1.2 \text{mA}$		5.0	5.8	6.5	V			
I <sub>GES</sub>	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				400	nA			

# **Dynamic Characteristics**

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$ $V_{CE} = 25V$			1950		
Coes	Output Capacitance				155		pF
C <sub>res</sub>	Reverse Transfer Capacitance	f=1MHz			115		
Q <sub>G</sub>	Gate charge	$V_{GE} = \pm 15V$ ; $V_{CE} = 600V$ $I_C = 35A$			0.27		μC
T <sub>d(on)</sub>	Turn-on Delay Time		Inductive Switching (25°C)		130		
Tr	Rise Time	$V_{GE} = \pm 15V$			20		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{CE} = 600V$ $I_{C} = 35A$			300		ns
T <sub>f</sub>	Fall Time	$R_{\rm G} = 12\Omega$			45		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (150°C)			150		
Tr	Rise Time	$V_{GE} = \pm 15V$ $V_{CE} = 600V$	$V_{GE} = \pm 15V$ $V_{GE} = 600V$		35		ns
T <sub>d(off)</sub>	Turn-off Delay Time	$I_{\rm C} = 35 {\rm A}$			350		115
T <sub>f</sub>	Fall Time	$R_G = 12\Omega$			80		
Eon	Turn-on Switching Energy	$V_{GE} = \pm 15V$	$T_J = 25^{\circ}C$		2.6		mJ
Lon	run-on Switching Energy	$V_{CE} = 600V$	$T_{J} = 150^{\circ}C$		4		1115
E <sub>off</sub>	Turn-off Switching Energy	$I_{\rm C} = 35 \text{A}$	$T_J = 25^{\circ}C$		2		mJ
Loff	Turn-on Switching Energy	$R_G = 12\Omega$	$T_{\rm J} = 150^{\circ}{\rm C}$		3		1115
I <sub>sc</sub>	Short Circuit data		$V_{GE} \le 15V$ ; $V_{Bus} = 900V$ $t_p \le 10\mu s$ ; $T_j = 150^{\circ}C$		140		А

## Reverse diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage			1200			V
I <sub>RM</sub>	Maximum Davana Laskaga Cumant	V <sub>R</sub> =1200V	$T_j = 25^{\circ}C$			100	۸
IRM	Maximum Reverse Leakage Current	<b>v</b> <sub>R</sub> -1200 <b>v</b>	$T_{j} = 150^{\circ}C$			500	μA
I <sub>F</sub>	DC Forward Current		$Tc = 80^{\circ}C$		30		Α
	Diode Forward Voltage	$I_F = 30A$			2.6	3.1	
V <sub>F</sub>		$I_F = 60A$		3.2		V	
		$I_F = 30A$	$T_{i} = 125^{\circ}C$		1.8		
t <sub>rr</sub>	Reverse Recovery Time	$ \begin{array}{c c} I_{\rm F} = 30A & T_{\rm j} = \\ V_{\rm R} = 800V & T_{\rm j} = \\ di/dt = 200A/\mu s & T_{\rm j} = \end{array} $	$T_j = 25^{\circ}C$		300		ns
ι <sub>rr</sub>			$T_{j} = 125^{\circ}C$		380		115
Q <sub>rr</sub>	Reverse Recovery Charge		$T_j = 25^{\circ}C$		360		nC
			$T_{j} = 125^{\circ}C$		1700		ne



# APTGL40H120T1G

### Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

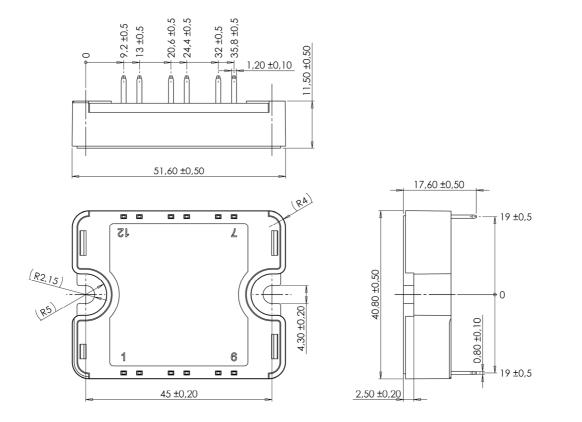
Symbol	Characteristic		Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
B <sub>25/85</sub>	T <sub>25</sub> =298.15 K			3952		K
$\Delta B/B$		T <sub>c</sub> =100°C		4		%
	D					

 $R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$  T: Thermistor temperature R<sub>T</sub>: Thermistor value at T

### Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit
R <sub>thJC</sub>	Junction to Case Thermal Resistance		IGBT			0.68	°C/W
			Diode			1.2	C/W
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
TJ	Operating junction temperature range			-40		175	
T <sub>STG</sub>	Storage Temperature Range		-40		125	°C	
T <sub>C</sub>	Operating Case Temperature			-40		100	
Torque	Mounting torque	To heatsink	M4	2		3	N.m
Wt	Package Weight					80	g

### SP1 Package outline (dimensions in mm)



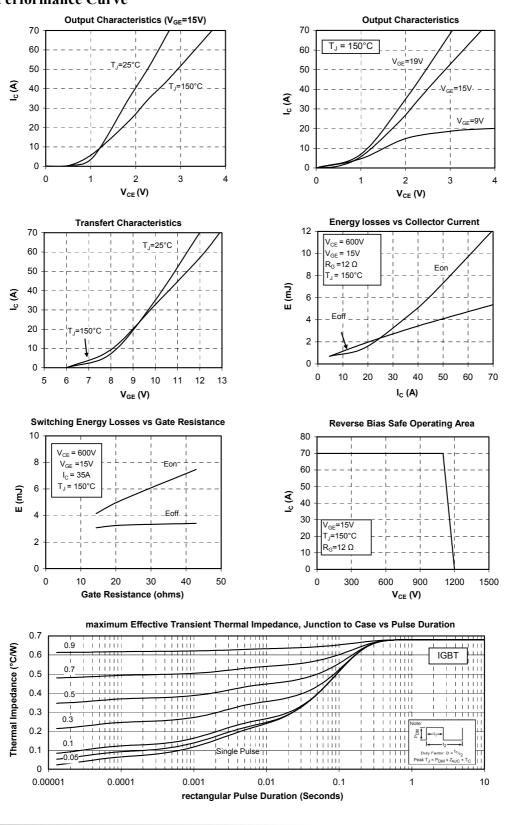
See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

www.microsemi.com

3 - 6



### **Typical Performance Curve**

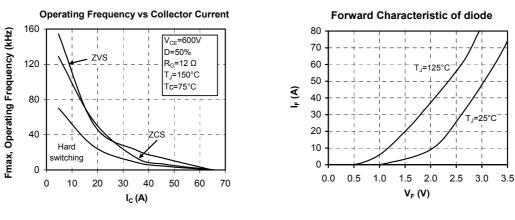


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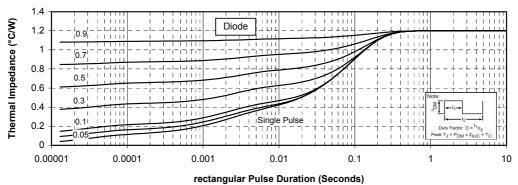
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# APTGL40H120T1G



maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration





# APTGL40H120T1G

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